

Search Notes

Application/Control No.

10/697,558

Examiner

Sophia S. Chen

Applicant(s)/Patent under
Reexamination

HAYASHI ET AL.

Art Unit

2852

SEARCHED

Class	Subclass	Date	Examiner
399	258	3/22/2005	SC
	262		
	260		
	120		
	119		
222	DIG.1	↓	↓

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Text Search (see printout)	3/22/2005	SC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner